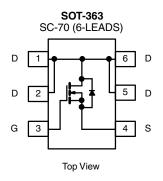




N-Channel 12 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}(\Omega)$ (Max.)	I _D (A) ^a	Q _g (Typ.)		
	0.020 at V _{GS} = 4.5 V	4			
12	0.024 at V _{GS} = 2.5 V	4	13.1 nC		
	0.030 at V _{GS} = 1.8 V	4			



Ordering Information:

Si1442DH-T1-GE3 (Lead (Pb)-free and Halogen-free)

FEATURES

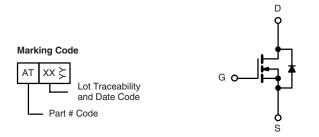
- TrenchFET® Power MOSFET
- 100 % R_g Tested
- Material categorization: For definitions of compliance please see www.vishay.com/doc?99912



HALOGEN FREE

APPLICATIONS

- Load Switch and Battery Switch for Portable Devices
- DC/DC Converters
- Low On-Resistance for Low Voltage Drop



N-Channel MOSFET

Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V _{DS}	12			
Gate-Source Voltage		V _{GS}	± 8	V	
	T _F = 25 °C		4 ^a		
Continuous Dusin Commant /T 450 °C\	T _F = 70 °C		4 ^a	A	
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	4a, b, c		
	T _A = 70 °C		4a, b, c		
Pulsed Drain Current (t = 300 μs)	I _{DM}	20			
Continuous Source-Drain Diode Current	T _F = 25 °C		2.3		
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	1.3 ^{b, c}		
	T _F = 25 °C		2.8		
Mayimum Dayyar Dissination	T _F = 70 °C	В	1.8	w	
Maximum Power Dissipation	T _A = 25 °C	P _D	1.56 ^{b, c}		
	T _A = 70 °C		1 ^{b, c}		
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 150	°C		
Soldering Recommendations (Peak Temperature		260			

THERMAL RESISTANCE RATINGS						
Parameter	Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient ^{b, d}	t ≤ 5 s	R _{thJA}	60	80	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	34	45	C/VV	

Notes:

- a. T_F = 25 °C, package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 5 s.
- d. Maximum under steady state conditions is 125 °C/W.

Document Number: 63772 S12-0546-Rev. A, 12-Mar-12 For technical support, please contact: pmostechsupport@vishav.com

Si1442DH

Vishay Siliconix



V _{SS(m)} Temperature Coefficient Δ/ _{SS(m)} /T _J V _{DS} = V _{GS} , I _D = 250 μA 0.4 1 Gate-Source Threshold Voltage I _{GSS} V _{DS} = 0 V, V _{GS} = 8 V ± ± 100 Zero Gate Voltage Drain Current I _{GSS} V _{DS} = 12 V, V _{GS} = 0 V 1 On-State Drain Current ^a I _{D(on)} V _{DS} = 12 V, V _{GS} = 0 V, T _J = 55 °C 10 Drain-Source On-State Resistance ^a P _{DS} (on) V _{DS} = 4.5 V, I _D = 6 A 0.017 0.020 Drain-Source On-State Resistance ^a 9 _{Is} V _{DS} = 6 V, I _D = 6 A 0.017 0.020 Poward Transconductance ^a 9 _{Is} V _{DS} = 6 V, I _D = 6 A 33 0.023 0.030 Foward Transconductance ^a 9 _{Is} V _{DS} = 6 V, I _D = 6 A 33 0.023 0.030 Foward Transconductance ^a 9 _{Is} V _{DS} = 6 V, V _{DS} = 0 V, I = 1 MHz 323 0.030 Poyantic ^b 0 V _{DS} = 6 V, V _{GS} = 0 V, I = 1 MHz 323 0.030 Output Capacitance C _{Iss} V _{DS} = 6 V, V _{GS} = 8 V, I _D = 7 A 21.8 33 Total Gate Charge Q _g V _{DS} = 6 V, V _{GS} = 8	SPECIFICATIONS (T _J = 25 °C, unless otherwise noted)							
Drain-Source Breakdown Voltage V _{DS} V _{DS} Temperature Coefficient Δ V_{DS/T_J} V _{GS(m)} Temperature Coefficient Δ V_{DS/T_J} V _{DS(m)} Temperature Coefficient Δ $V_{DS(m)}$ Temperature Coefficient $V_{DS(m)}$ Temperature $V_{DS(m)}$ Tem	Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
V _{DS} Temperature Coefficient ΔV _{DS} /T _J I _D = 250 μA 5 4 V _{SS(th)} Temperature Coefficient ΔV _{OS(th)} T _J V _{DS} = V _{OS} , I _D = 250 μA 0.4 1 Gate-Source Threshold Voltage V _{OS} (th) V _{DS} = V _{OS} , I _D = 250 μA 0.4 1 Zero Gate Voltage Drain Current I _{DSS} V _{DS} = 0 V, V _{OS} = ±8 V ±100 Zero Gate Voltage Drain Current ^a I _{DSS} V _{DS} = 12 V, V _{OS} = 0 V 1 On-State Drain Current ^a I _D (on) V _{DS} = 12 V, V _{OS} = 0 V 15 On-State Drain Current ^a I _D (on) V _{DS} = 5 V, V _{OS} = 4.5 V 15 Drain-Source On-State Resistance ^a P _{DS} (on) V _{OS} = 2.5 V, I _D = 6 A 0.017 0.020 Drain-Source On-State Resistance ^a 9ts V _{DS} = 6 V, I _D = 6 A 0.017 0.020 Drain-Source Con-State Resistance ^a 9ts V _{DS} = 6 V, I _D = 6 A 0.017 0.020 Dynamic* Dynamic* <td>Static</td> <td></td> <td></td> <td></td> <td></td> <td></td> <td></td>	Static							
V _{GS(III)} Temperature Coefficient ΔV _{GS(III)} Temperature Coefficient ΔV _{GS(III)} Temperature Coefficient ΔV _{GS(III)} Temperature Coefficient ΔV _{GS(III)} Temperature Coefficient - 2.7 Image: Composition of the properature of th	•	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	12			V	
Vastern Temperature Coefficient ΛVGS(H)/DI VDS = VGS, ID = 250 μA 0.4 1 Gate-Source Threshold Voltage IGSS VDS = VGS, ID = 250 μA 0.4 1 Zero Gate Voltage Drain Current IGSS VDS = 0 V, VGS = 8 V ± 100 On-State Drain Current ^Q IDSS VDS = 12 V, VGS = 0 V, TJ = 55 °C 10 On-State Drain Current ^Q ID(ID) VDS = 5 V, VGS = 4.5 V 15 Drain-Source On-State Resistance ^A RDS(en) VGS = 4.5 V, ID = 6 A 0.017 0.020 Drain-Source On-State Resistance ^A PBS(en) VGS = 4.5 V, ID = 5 A 0.019 0.024 VGS = 1.8 V, ID = 5 A 0.019 0.024 0.023 0.030 0.030 Forward Transconductance ^A Pgs VDS = 6 V, VGS = 0 V, In = 6 A 33 0.023 0.030 Forward Transconductance ^A Pgs VDS = 6 V, VGS = 0 V, In = 1 MHz 323 0.030 Forward Transconductance ^A Pgs VDS = 6 V, VGS = 8 V, ID = 7 A 21.8 33 Dyparticle QG VDS = 6 V, VGS = 8 V, ID = 7 A 21.8 33	V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	In = 250 µA		5		mV/°C	
Sase Source Leakage Sase Sas	V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	10 - 200 μ. τ		- 2.7		1110/ C	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	0.4		1	V	
Tosa Voitage Drain Current Tosa Vois = 12 V. Vois = 0 V. T.J = 55 °C 10 10	Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$			± 100	nA	
On-State Drain Current ^a I _{D(on)} V _{DS} = 12 V, V _{GS} = 4.5 V 15 10 Drain-Source On-State Resistance ^a R _{DS} (on) V _{DS} = 4.5 V, V _{DS} = 6 A 0.017 0.020 Drain-Source On-State Resistance ^a 9ts V _{DS} = 5.5 V, V _{DS} = 5 A 0.019 0.024 V _{SS} = 1.8 V, I _D = 3 A 0.023 0.030 0.030 Eroward Transconductance ^a 9ts V _{DS} = 6 V, I _D = 6 A 33 0.023 0.030 Dynamic ^b Unput Capacitance C ₁₈₈ V _{DS} = 6 V, V _{GS} = 0 V, f = 1 MHz 323 1010	Zava Cata Valtaga Dvain Current	1	$V_{DS} = 12 \text{ V}, V_{GS} = 0 \text{ V}$			1		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Zero Gate voltage Drain Current	DSS	$V_{DS} = 12 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10	μΑ	
Drain-Source On-State Resistance ^a R _{DS(on)} V _{GS} = 2.5 V, I _D = 5 A 0.019 0.024 V _{GS} = 1.8 V, I _D = 3 A 0.023 0.030 Forward Transconductance ^a 9fs V _{DS} = 6 V, I _D = 6 A 33 Import State Resistance Dynamic ^b Unput Capacitance C _{Iss} 1010 Import Capacitance 102 102 Import Capacitance 103 Import Capacitance 104 Import Capacitance	On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	15			Α	
No			$V_{GS} = 4.5 \text{ V}, I_D = 6 \text{ A}$		0.017	0.020		
Proward Transconductance Proward Transcondu	Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 2.5 \text{ V}, I_D = 5 \text{ A}$		0.019	0.024	Ω	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $					0.023	0.030	1	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Forward Transconductance ^a	g _{fs}	$V_{DS} = 6 \text{ V}, I_{D} = 6 \text{ A}$		33		S	
$ \begin{array}{ c c c c c } \hline \text{Input Capacitance} & C_{\text{Iss}} \\ \hline \text{Output Capacitance} & C_{\text{Oss}} \\ \hline \text{Reverse Transfer Capacitance} & C_{\text{rss}} \\ \hline \text{Reverse Transfer Capacitance} & C_{\text{rss}} \\ \hline \text{Total Gate Charge} & Q_g \\ \hline \text{Gate-Source Charge} & Q_{gs} \\ \hline \text{Gate-Drain Charge} & Q_{gd} \\ \hline \text{Gate-Brain Charge} & Q_{gd} \\ \hline \text{Gate-Drain Charge} & Q_{gd} \\ \hline \text{Gate-Drain Charge} & Q_{gd} \\ \hline \text{Gate-Brain Charge} & Q_{gd} \\ \hline \text{Gate-Injain Charge} & Q_{gd} \\ \hline \text{Gate-Drain Charge} & Q_{gd} \\ \hline \text{Gate-Drain Charge} & Q_{gd} \\ \hline \text{Gate-Brain Charge} & Q_{gd} \\ \hline \text{Gate-Drain Charge} & Q_{gd} \\ \hline \text{Gate-Injain Charge} & Q_{gd} \\ \hline \text{Gate-Brain Charge} & Q_{gd} \\ \hline \text{Gate-Brain Charge} & Q_{gd} \\ \hline \text{Gate-Brain Charge} & Q_{gd} \\ \hline \text{Gate-Drain Charge} & Q_{gd} \\ \hline \text{Gate-Brain Charge} & Q_{gd} \\ \hline Gate-Brain Ch$		_			Ļ	ļ	<u> </u>	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$		Cies			1010		<u> </u>	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$			V _{DC} = 6 V. V _{CC} = 0 V. f = 1 MHz		+		pF	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$			50 7 do 7		+		-	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Therefore Trainerer Capacitaines		$V_{DS} = 6 \text{ V}, V_{GS} = 8 \text{ V}, I_{D} = 7 \text{ A}$			33		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Total Gate Charge	Ū					nC	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Gate-Source Charge				2			
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Gate-Drain Charge				2.7			
Turn-On Delay Time $t_{d(on)}$ $V_{DD} = 6 \text{ V}, R_L = 1.07 \Omega$ 13 20 Turn-Off Delay Time $t_{d(off)}$ $I_D \cong 5.6 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$ 22 33 Fall Time t_f 9 18 Turn-On Delay Time $t_{d(on)}$ 6 12 Rise Time t_f $V_{DD} = 6 \text{ V}, R_L = 1.07 \Omega$ 12 18 Turn-Off Delay Time t_f $I_D \cong 5.6 \text{ A}, V_{GEN} = 8 \text{ V}, R_g = 1 \Omega$ 22 33 Fall Time t_f $I_D \cong 5.6 \text{ A}, V_{GEN} = 8 \text{ V}, R_g = 1 \Omega$ 22 33 Drain-Source Body Diode Characteristics Continuous Source-Drain Diode Current I_S $I_C = 25 ^{\circ}C$ 4 Pulse Diode Forward Current I_{SM} 20 Body Diode Voltage V_{SD} $I_S = 5.6 \text{ A}, V_{GS} = 0 \text{ V}$ 0.75 1.2 Body Diode Reverse Recovery Charge Q_{rr} $I_F = 5.6 \text{ A}, \text{ dI/dt} = 100 \text{ A/μs}, T_J = 25 ^{\circ}C$ 7 14 Reverse Recovery Fall Time I_A I_A I_A I_A I_A	Gate Resistance	_	f = 1 MHz	0.3	1.6	3.2	Ω	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Turn-On Delay Time				8	16		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	•		$V_{DD} = 6 \text{ V}, R_1 = 1.07 \Omega$		13	20	-	
Fall Time t_f 9 18 Turn-On Delay Time $t_{d(on)}$ 6 12 Rise Time t_r $V_{DD} = 6 \text{ V}, R_L = 1.07 \Omega$ 12 18 Turn-Off Delay Time t_g t_g 22 33 Fall Time t_f 8 16 Drain-Source Body Diode Characteristics Continuous Source-Drain Diode Current t_g t_g t_g t_g 4 Pulse Diode Forward Current t_g	Turn-Off Delay Time				22	33		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	<u> </u>		3		-			
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$		· ·			_		ns	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$			$V_{DD} = 6 \text{ V}, R_1 = 1.07 \Omega$		12	18	1	
Fall Time t_f 8 16 Prain-Source Body Diode Characteristics Continuous Source-Drain Diode Current t_S $t_C = 25 ^{\circ}\text{C}$ 4 Pulse Diode Forward Current t_S $t_S = 5.6 ^{\circ}\text{A}$ $t_S = 5.6$	Turn-Off Delay Time		55		22	33		
			3		8	16		
	Drain-Source Body Diode Characterist				<u> </u>		L	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	•	1	T _C = 25 °C			4		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Pulse Diode Forward Current					20	A	
Body Diode Reverse Recovery Time t_{rr} Body Diode Reverse Recovery Charge Q_{rr} Reverse Recovery Fall Time t_a $I_F = 5.6 \text{ A, dl/dt} = 100 \text{ A/µs, T}_J = 25 \text{ °C}$ $19 30$ $7 14$ 13 13	Body Diode Voltage		I _S = 5.6 A, V _{GS} = 0 V		0.75	1.2	V	
Body Diode Reverse Recovery Charge Q_{rr} Reverse Recovery Fall Time t_a $I_F = 5.6 \text{ A, dl/dt} = 100 \text{ A/µs, T}_J = 25 \text{ °C}$ 13	•				-		ns	
Reverse Recovery Fall Time t_a $I_F = 5.6 \text{ A}, \text{ dl/dt} = 100 \text{ A/µs}, I_J = 25 \text{ C}$ 13		Reverse Recovery Charge Q				-	nC	
			$I_F = 5.6 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		+		1	
Reverse Recovery Rise Time I I I I I I I I I I I I I I I I I I	Reverse Recovery Rise Time				6		ns	

Notes:

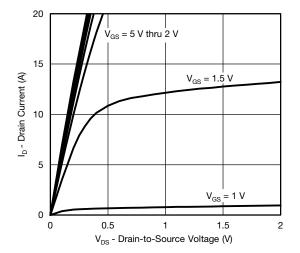
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

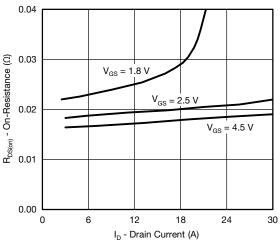
b. Guaranteed by design, not subject to production testing.



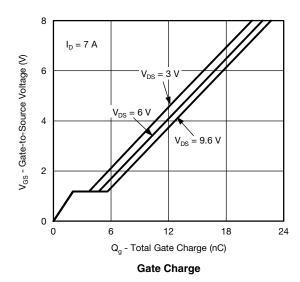
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

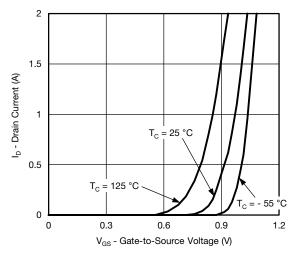


Output Characteristics

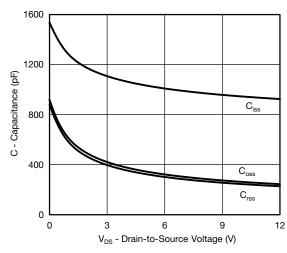


On-Resistance vs. Drain Current

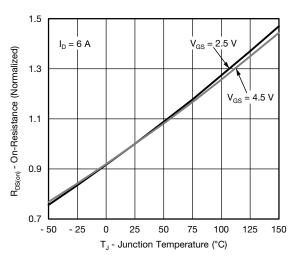




Transfer Characteristics



Capacitance

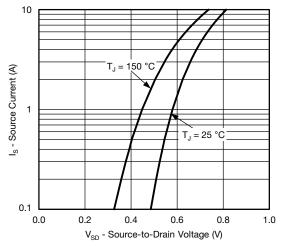


On-Resistance vs. Junction Temperature

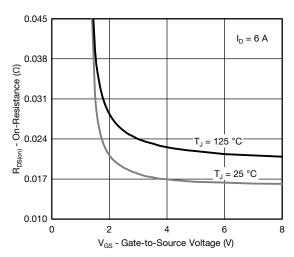
Si1442DH

Vishay Siliconix

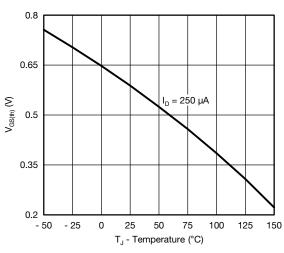
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



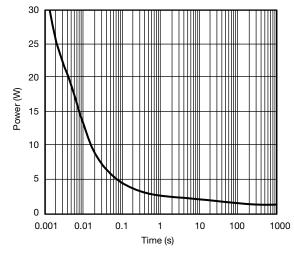




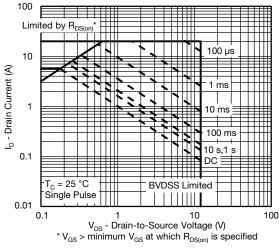
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



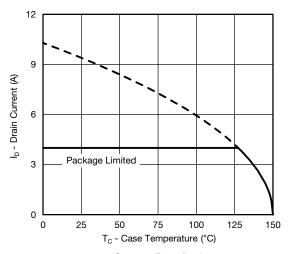
Single Pulse Power, Junction-to-Ambient



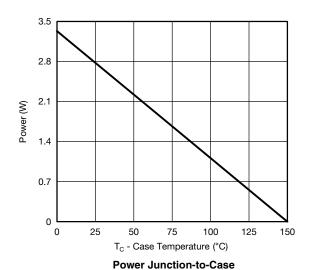
Safe Operating Area, Junction-to-Ambient

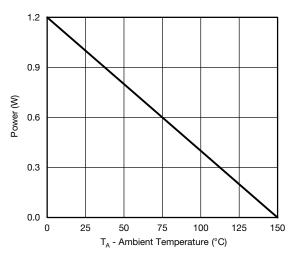


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Current Derating*





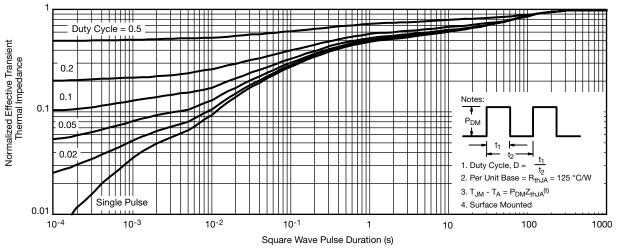
Power Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J(max.)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

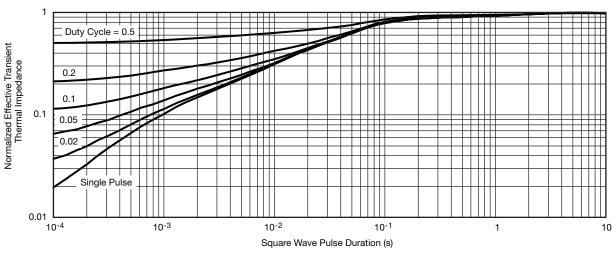
Si1442DH

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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



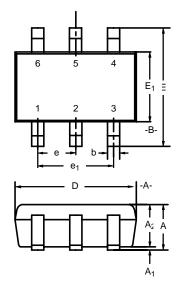
Normalized Thermal Transient Impedance, Junction-to-Foot

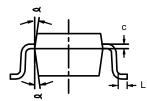
Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?63772.





SC-70: 6-LEADS





	MILLIMETERS			I	NCHE	S
Dim	Min	Nom	Max	Min	Nom	Max
Α	0.90	-	1.10	0.035	-	0.043
A ₁	_	-	0.10	_	_	0.004
A ₂	0.80	-	1.00	0.031	_	0.039
b	0.15	-	0.30	0.006	_	0.012
С	0.10	-	0.25	0.004	-	0.010
D	1.80	2.00	2.20	0.071	0.079	0.087
Е	1.80	2.10	2.40	0.071	0.083	0.094
E ₁	1.15	1.25	1.35	0.045	0.049	0.053
е		0.65BSC			0.026BSC	;
e ₁	1.20	1.30	1.40	0.047	0.051	0.055
L	0.10	0.20	0.30	0.004	0.008	0.012
۵	7°Nom 7°Nom					
ECN: S-03946—Rev. B, 09-Jul-01						

DWG: 5550





Single-Channel LITTLE FOOT® SC-70 6-Pin MOSFET Copper Leadframe Version Recommended Pad Pattern and Thermal Performance

INTRODUCTION

The new single 6-pin SC-70 package with a copper leadframe enables improved on-resistance values and enhanced thermal performance as compared to the existing 3-pin and 6-pin packages with Alloy 42 leadframes. These devices are intended for small to medium load applications where a miniaturized package is required. Devices in this package come in a range of on-resistance values, in n-channel and p-channel versions. This technical note discusses pin-outs, package outlines, pad patterns, evaluation board layout, and thermal performance for the single-channel version.

BASIC PAD PATTERNS

See Application Note 826, Recommended Minimum Pad Patterns With Outline Drawing Access for Vishay Siliconix MOSFETs, (http://www.vishay.com/doc?72286) for the basic pad layout and dimensions. These pad patterns are sufficient for the low to medium power applications for which this package is intended. Increasing the drain pad pattern yields a reduction in thermal resistance and is a preferred footprint. The availability of four drain leads rather than the traditional single drain lead allows a better thermal path from the package to the PCB and external environment.

PIN-OUT

Figure 1 shows the pin-out description and Pin 1 identification. The pin-out of this device allows the use of four pins as drain leads, which helps to reduce on-resistance and junction-to-ambient thermal resistance.

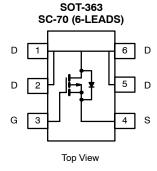


FIGURE 1.

For package dimensions see outline drawing SC-70 (6-Leads) (http://www.vishay.com/doc?71154)

EVALUATION BOARDS — SINGLE SC70-6

The evaluation board (EVB) measures 0.6 inches by 0.5 inches. The copper pad traces are the same as in Figure 2. The board allows examination from the outer pins to 6-pin DIP connections, permitting test sockets to be used in evaluation testing. See Figure 3.

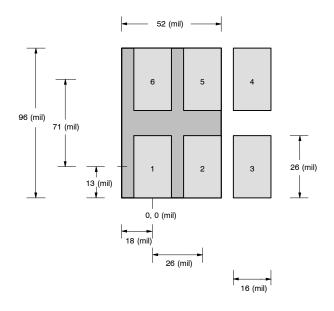
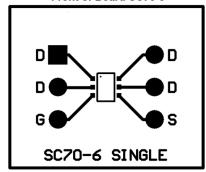


FIGURE 2. SC-70 (6 leads) Single

The thermal performance of the single 6-pin SC-70 has been measured on the EVB, comparing both the copper and Alloy 42 leadframes. This test was first conducted on the traditional Alloy 42 leadframe and was then repeated using the 1-inch² PCB with dual-side copper coating.



Front of Board SC70-6



Back of Board SC70-6

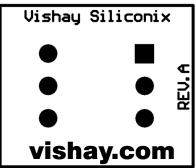


FIGURE 3.

THERMAL PERFORMANCE

Junction-to-Foot Thermal Resistance (Package Performance)

The junction to foot thermal resistance is a useful method of comparing different packages thermal performance.

A helpful way of presenting the thermal performance of the 6-Pin SC-70 copper leadframe device is to compare it to the traditional Alloy 42 version.

Thermal performance for the 6-pin SC-70 measured as junction-to-foot thermal resistance, where the "foot" is the drain lead of the device at the bottom where it meets the PCB. The junction-to-foot thermal resistance is typically 40°C/W in the copper leadframe and 163°C/W in the Alloy 42 leadframe - a four-fold improvement. This improved performance is obtained by the enhanced thermal conductivity of copper over Alloy 42.

Power Dissipation

The typical $R\theta_{JA}$ for the single 6-pin SC-70 with copper leadframe is 103°C/W steady-state, compared with 212°C/W for the Alloy 42 version. The figures are based on the 1-inch² FR4 test board. The following example shows how the thermal resistance impacts power dissipation for the two different leadframes at varying ambient temperatures.

ALLOY 42 LEADFRAME				
Room Ambient 25 °C Elevated Ambient 60 °C				
$P_D = \frac{T_{J(max)} - T_A}{R\theta_{JA}}$	$P_D = \frac{T_{J(max)} - T_A}{R\theta_{JA}}$			
$P_{D} = \frac{150^{\circ}C - 25^{\circ}C}{212^{\circ}C/W}$	$P_{D} = \frac{150^{\circ}C - 25^{\circ}C}{212^{\circ}C/W}$			
$P_D = 590 \text{ mW}$	$P_D = 425 \text{ mW}$			

COOPER LEADFRAME				
Room Ambient 25 °C	Elevated Ambient 60 °C			
$P_{D} = \frac{T_{J(max)} - T_{A}}{R\theta_{JA}}$ $P_{D} = \frac{150^{\circ}C - 25^{\circ}C}{124^{\circ}C/W}$	$P_{D} = \frac{T_{J(max)} - T_{A}}{R\theta_{JA}}$ $P_{D} = \frac{150^{\circ}C - 60^{\circ}C}{124^{\circ}C/W}$			
$P_{D} = 1.01 \text{ W}$	P _D = 726 mW			

As can be seen from the calculations above, the compact 6-pin SC-70 copper leadframe LITTLE FOOT power MOSFET can handle up to 1 W under the stated conditions.

Testing

To further aid comparison of copper and Alloy 42 leadframes, Figure 5 illustrates single-channel 6-pin SC-70 thermal performance on two different board sizes and two different pad patterns. The measured steady-state values of $R\theta_{JA}$ for the two leadframes are as follows:

LITTLE FOOT 6-PIN SC-70					
	Alloy 42	Copper			
1) Minimum recommended pad pattern on the EVB board V (see Figure 3.	329.7°C/W	208.5°C/W			
Industry standard 1-inch ² PCB with maximum copper both sides.	211.8°C/W	103.5°C/W			

The results indicate that designers can reduce thermal resistance ($R\theta_{1\Delta}$) by 36% simply by using the copper leadframe device rather than the Alloy 42 version. In this example, a 121°C/W reduction was achieved without an increase in board area. If increasing in board size is feasible, a further 105°C/W reduction could be obtained by utilizing a 1-inch² square PCB area.

The copper leadframe versions have the following suffix:

Single: Si14xxEDH Dual: Si19xxEDH Complementary: Si15xxEDH

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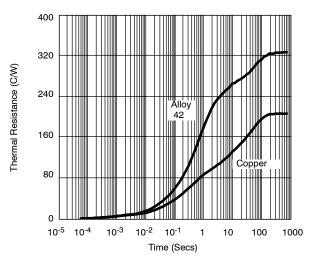


FIGURE 4. Leadframe Comparison on EVB

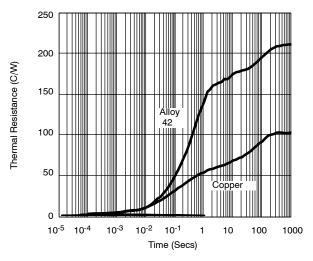


FIGURE 5. Leadframe Comparison on Alloy 42 1-inch² PCB



RECOMMENDED MINIMUM PADS FOR SC-70: 6-Lead



Recommended Minimum Pads Dimensions in Inches/(mm)

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